FAIRCHILD

SEMICONDUCTOR®

SGP6N60UFD

Ultra-Fast IGBT

General Description

Fairchild's UFD series of Insulated Gate Bipolar Transistors (IGBTs) provides low conduction and switching losses. The UFD series is designed for applications such as motor control and general inverters where high speed switching is a required feature.

Features

- High speed switching
- Low saturation voltage : $V_{CE(sat)} = 2.1 \text{ V} @ I_C = 3 \text{ A}$
- High input impedance
- CO-PAK, IGBT with FRD : t_{rr} = 35ns (typ.)

Applications

AC & DC motor controls, general purpose inverters, robotics, and servo controls.



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Description Collector-Emitter Voltage		SGP6N60UFD	Units V	
V _{CES}			600		
V _{GES}	Gate-Emitter Voltage		± 20	V	
_	Collector Current	@ T _C = 25°C	6	A	
I _C	Collector Current	@ T _C = 100°C	3	A	
I _{CM (1)}	Pulsed Collector Current		25	A	
I _F	Diode Continuous Forward Current	@ T _C = 100°C	4	A	
I _{EM}	Diode Maximum Forward Current		25	A	
P _D	Maximum Power Dissipation	@ T _C = 25°C	30	W	
	Maximum Power Dissipation	@ T _C = 100°C	12	W	
TJ	Operating Junction Temperature		-55 to +150	°C	
T _{stg}	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C	

Notes : (1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

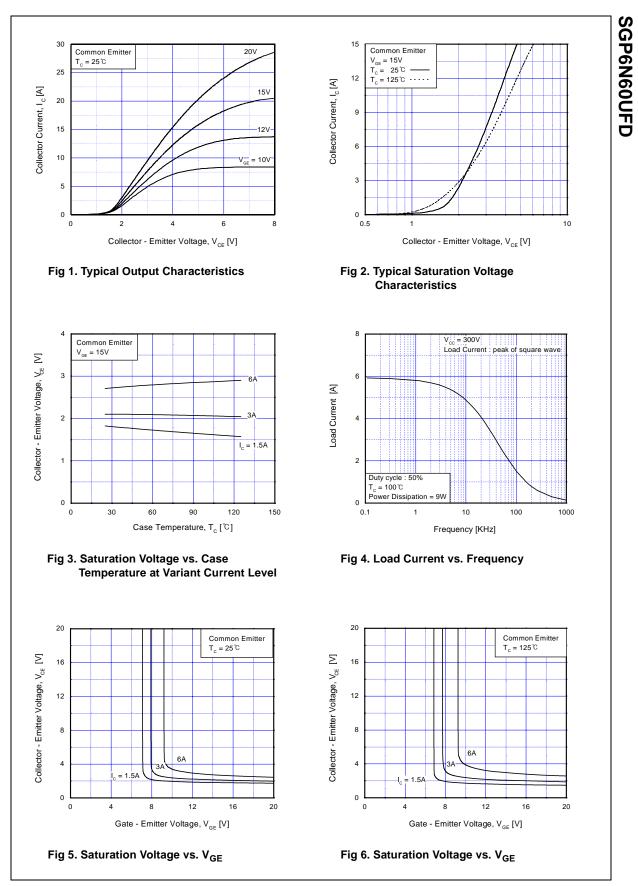
Symbol	Parameter	Тур.	Max.	Units
R _{θJC} (IGBT)	Thermal Resistance, Junction-to-Case		4.0	°C/W
R _{0JC} (DIODE)	Thermal Resistance, Junction-to-Case		7.0	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

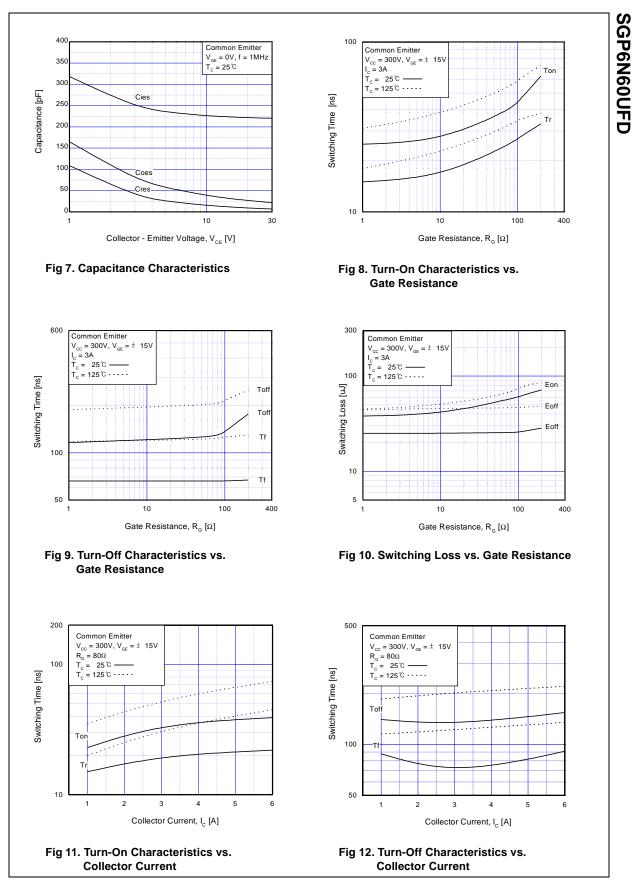
IGBT

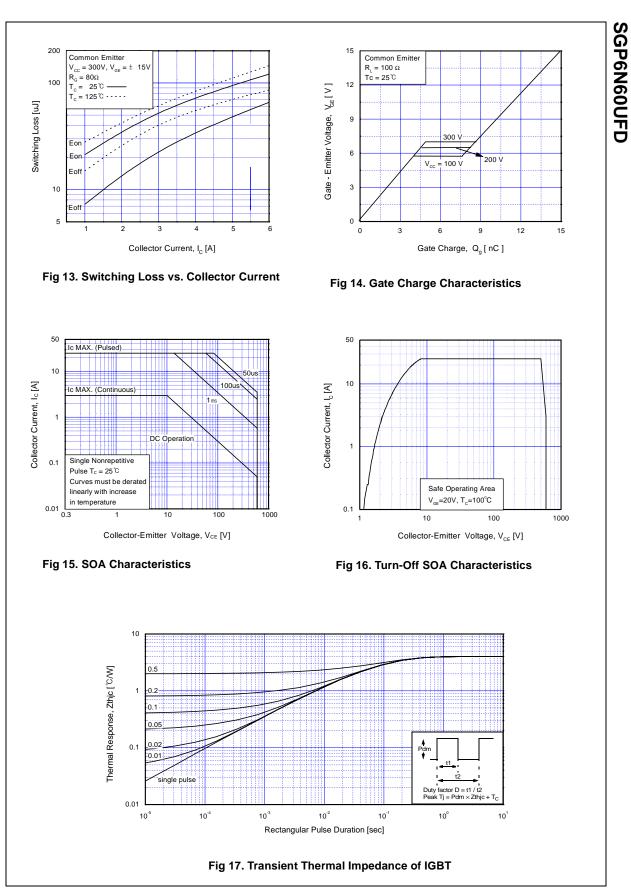
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
)ff Cha	racteristics					
V _{CES}	Collector-Emitter Breakdown Voltage	0- 0				V
B _{VCES} /	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0V, I_C = 1mA$		0.6		V/°C
ES	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
ES	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
n Cha	racteristics					
GE(th)	G-E Threshold Voltage	$I_{C} = 3mA, V_{CE} = V_{GE}$	3.5	4.5	6.5	V
	Collector to Emitter	$I_{\rm C} = 3A, V_{\rm GE} = 15V$		2.1	2.6	V
CE(sat)	Saturation Voltage	$I_{\rm C} = 6A, V_{\rm GE} = 15V$		2.6		V
-			·		•	
-	c Characteristics		1	1	1	
ies	Input Capacitance	V _{CE} = 30V, V _{GE} = 0V,		220		pF
es	Output Capacitance	f = 1MHz		22		pF
es	Reverse Transfer Capacitance			7		pF
witchi	ng Characteristics					
(on)	Turn-On Delay Time			15		ns
(on)	Turn-On Delay Time Rise Time	_		25		ns
(on)	Turn-On Delay Time Rise Time Turn-Off Delay Time	V _{CC} = 300 V, I _C = 3A,		25 60	 130	ns ns
(on) (off)	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$R_{G} = 80\Omega, V_{GE} = 15V,$		25 60 70	 130 150	ns ns ns
(on) (off) on	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss			25 60 70 57	 130	ns ns ns uJ
i(on) i(off) on off	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss	$R_{G} = 80\Omega, V_{GE} = 15V,$	 	25 60 70 57 25	 130 150 	ns ns ns uJ uJ
(off) on off ts	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss	$R_{G} = 80\Omega, V_{GE} = 15V,$	 	25 60 70 57 25 82	 130 150 120	ns ns ns uJ uJ uJ
(on) (off) on off	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Turn-On Switching Loss Turn-Off Switching Loss Total Switching Loss Turn-On Delay Time	$R_{G} = 80\Omega, V_{GE} = 15V,$	 	25 60 70 57 25 82 22	 130 150 120 	ns ns uJ uJ uJ ns
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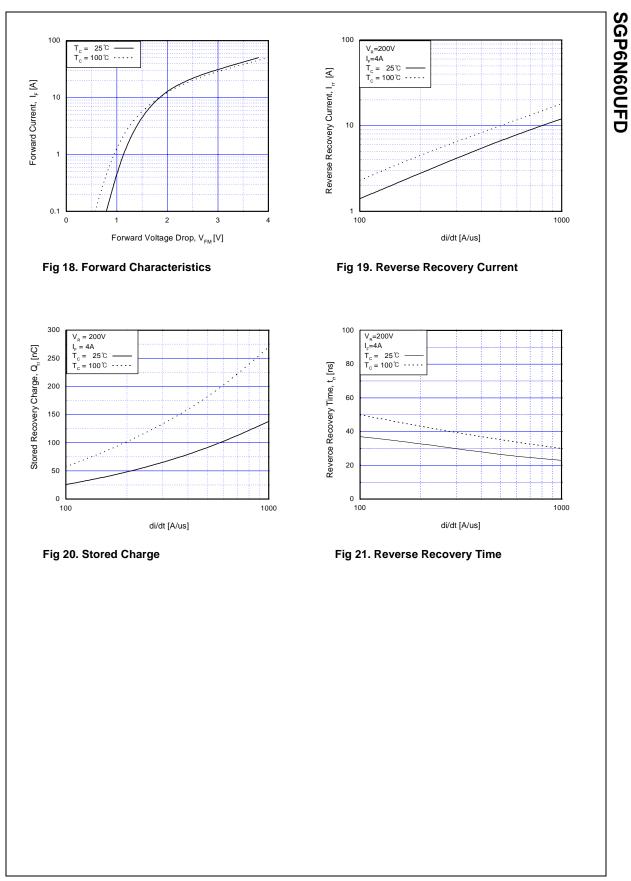
Electrical Characteristics of DIODE T_C = 25°C unless otherwise noted

Symbol Pa V _{FM} Diode Forward	Parameter	Test Conditions		Min.	Тур.	Max.	Units
		I _E = 4A	$T_{C} = 25^{\circ}C$		1.4	1.7	V
	Didde Forward Voltage	$I_F = 4A$	$T_{C} = 100^{\circ}C$		1.3		v
+	Diada Bayaraa Baaayary Tima		$T_{C} = 25^{\circ}C$		35	52	20
t _{rr}	rr Diode Reverse Recovery Time		$T_{C} = 100^{\circ}C$		53		ns
1	Diode Peak Reverse Recovery	I _F = 4A,	$T_{C} = 25^{\circ}C$		3.5	5.0	А
rr	r Current	di/dt=200A/us	$T_{C} = 100^{\circ}C$		4.5		
Q _{rr}	Diode Reverse Recovery Charge		$T_{C} = 25^{\circ}C$		60	135	20
			T _C = 100°C		120		nC









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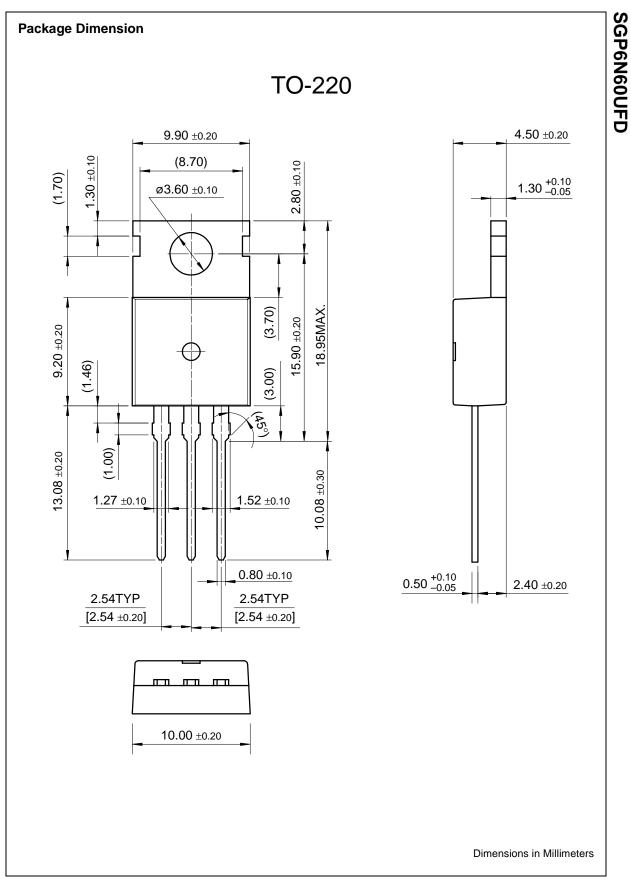
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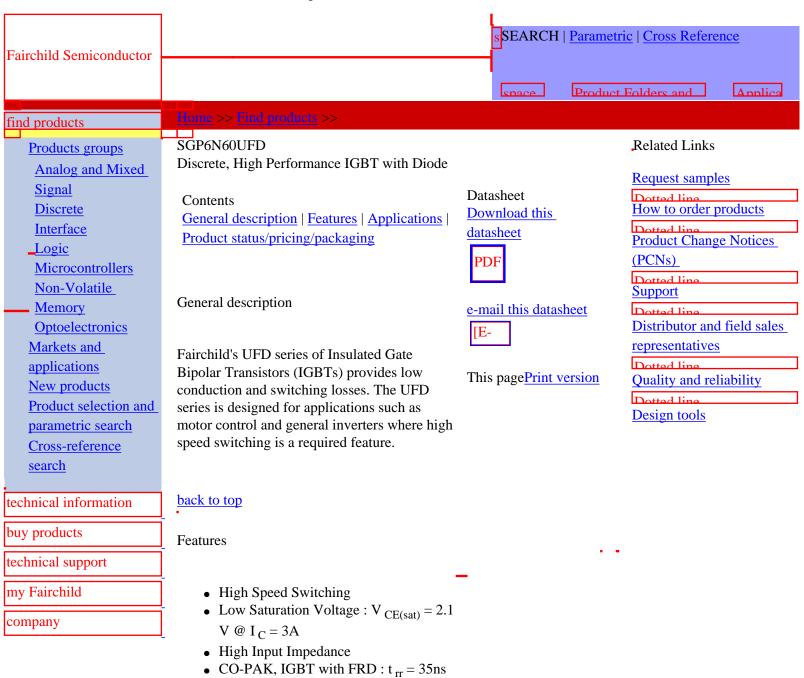
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Applications

AC &DC Motor controls,General Purpose Inverters, Robotics, Servo Controls

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
SGP6N60UFDTU	Full Production	\$0.95	TO-220	3	RAIL

* 1,000 piece Budgetary Pricing

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